	151EXB008058
	November 26.2008
	■ New □ Changed

PRODUCT SPECIFICATION FOR APPROVAL

Product Description	:	Chip Resistor Array (RoHS Compliance)
Product Part Number	:	$EXB24V * * * \Box X$

Country of Origin	:	JAPAN, CHINA, MALAYSIA
Applications	:	Standard electronic equipment

*If you approve this specification, please fill in and sign the below and return 1 copy to us.

Approval No	:	
Approval Date	:	
Executed by	:	
		(signature)
Title	:	
Dept.	:	

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Subject				Spec. No. 151-EXB-24V01N	
Chip Resistor Array	y PRODUCT SPEC	151°EAD°24V011			
Part No.	EXB24	4V		8-1	
1. Dimension					
$ \stackrel{A}{\longleftrightarrow} 2 \stackrel{-\phi D}{\longrightarrow} $	F			(a) D (a) D	
	(1)Substrate	(2)Protective coating	(3)Resistive element	
		lumina	Resin	Ruthenium oxide	
)Termination	(5)Termination	(6) Termination	
		(Inner)	(Between)	(Outer)	
	d.	g or Ag/Pd de:Resin+Metal	Ni Plating	Sn Plating	
				<u> </u>	
	a-a' sectional				
	(1) (2) (3) (4)				
	<u>19</u> y	(للمسمعيني)			
	L W		A	В	
Dimension(mm)	1.00±0.10 1.00±	$0.10 0.35 \pm 0.$	10 0.40±0.10	0.18 ± 0.10	
	D P C (): Reference				
Dimension(mm)	Dimension(mm) (0.30) (0.65) 0.25±0.10				
2. Power derating cu	ırve				
5 100 -55°C	70°C				
			N - 4 4 4 4		
Category temperature range					
us rate	40 -55°C to +125°C				
		125°C			
-60 -40 -2	20 0 20 40 60 80 100	0 120 140 160			
	Ambient Temperature	(°C)			
	Fig. 1				
3. Ratings					
	Rated Value	Explanation			
		When used a	t ambient tempera		
Rated Dissipation	0.063 W / element		issipation should	be reduced as	
r ····	Chin jumpor · Roto	ő		an 50 mO	
-	equation below, and when the rated voltage exceeds the limitin				
	element voltage, the limiting element voltage should the maximum				
Working Voltage	king Voltage $F = \sqrt{P \times R}$ Limiting element voltage : 50 V				
(RCWV)					
3. Ratings Item Rated Dissipation Rated Continuous Working Voltage	Ambient Temperatured Fig. 1 Rated Value 0.063 W / element Chip jumper : Rate The rated voltage equation below, a element voltage, t working voltage. $E = \sqrt{P \times R}$	Explanation When used a the rated d shown in Fig. d current 1 A (R e of each resist nd when the r he limiting eler Limiting eler	-55°C to +125°C t ambient tempera issipation should <u>1</u> esistance is less that or should be calc rated voltage exceed nent voltage shoul ment voltage : 50 V	ture over 70 °C, be reduced as an 50 m Ω) ulated from the eds the limiting d the maximum	

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Item	Rated Value Explanation			
Maximum overload voltage	Voltage should be $2.5 \times E$. When the voltage exceeds the maximum overload voltage, the value shown below should be the maximum overload voltage. Maximum overload voltage: 100V Chip jumper: Max. overload current 2A			
Resistance tolerance	SignTolerance for resistanceJ±5%0Chip Jumper			
Range of rated resistance for manufacture	$\begin{array}{ c c c c c }\hline Tolerance & Resistance range & Series \\ \hline J & 1.0 \ \Omega \ to \ 1.0 \ M\Omega & E^{-}24 \\ \hline 0 & Less \ than \ 50 \ m\Omega & - \\ \hline \end{array}$			

4. Explanation of part number



5. Appearance & Construction

Item	Specifications	Explanation
Appearance & Construction	that do not fade easily flaw, pinhole and 2.The electrode sho dimensions. The unevenness, flaw 3.The electrode sho resistive element	buld be printed uniformly, as shown in the plating should not fade easily, and should avoid w, pinhole, projection and discoloration. buld be connected electrically, mechanically to

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As far as there	e shall be not designa	tion especially	, the following test and mea	surement shall be
operated und	der normal temperatu	ure(15 °C to 38	5 °C), normal humidity(25	%RH to 75 %RH),
normal atmo	spheric pressure(86 k	Pa to 106 kPa)		
6. Performance	Specification			
Item	Specification		Test methods	
Item	Resistor	Jumper		
DC resistance	DC resistance v within the specifie		Measuring voltage: refer to	o JIS-C5201-1
	within the specific	eu toierance	At 20 °C, 65 %RH Natural resistance chang	re per temperature
	Resistance	TCR	degree centigrade.	,e per temperature
	<10Ω	⁺⁶⁰⁰ ₋₁₀₀ ×10 ⁻⁶ / °C	TCR= $\frac{R_2 - R_1}{R_1 \times (t_2 - t_1)}$	
Temperature	10Ω to $1M\Omega$ ±	200×10 ⁻⁶ / °C	$R_1 \times (t_2 - t_1)$ $R_1 \colon \text{Resistance value at}$	
coefficient			$temperature(t_1)$	
	Chip jumper :		R_2 : Resistance value at	test
	Less than	$50 \text{ m}\Omega$	temperature(t ₂) $t_2 - t_1 = 100 \text{ °C}, t_1 = 25 \text{ °C}$	C
		Less than	Resistors shall be applied	
Overload	±(2 %+0.1 Ω)	$50 \text{ m}\Omega$	voltage for 5 seconds.	
			Maximum over load voltag Resistors shall be subjected	
Intermittent Overload		T	2.5 times the rated volt	
	±(5 %+0.1 Ω)	Less than 50 mΩ	second with pause of 2	
			tests. Maximum over load voltag	o shall be 100 V
	No evidence of fla	shover.	AC 100V between substra	
Dielectric Withstanding	mechanical damag	ge, arcing or	for 1 minute.	
This tailaing	insulation breakde	own.		

7. Mechanical characteristic

Min. 1,000 MΩ

Insulation

Resistance

Item	Specification		Test methods	
Item	Resistor	Jumper	Test methods	
Adhesion			Load of 9.8N shall be applied to a side of resistor for 10s, which is placed on printing	
Adhesion	±(1 %+0.05 Ω)	Less than 50 mΩ	board Printing board: Glass epoxy (t = 1.0 mm)	
Bend strength of the face plating	No mechanical dar	nage	Substrate: Glass epoxy(t = 1.0 mm) Span: 90 mm	
	±(1 %+0.05 Ω)	Less than 50 mΩ	Bending distance: 3 mm (10 seconds)	
Solderability	Termination show uniformly with sol (min. 95 % coverage	der.	Resistors shall be dipped in the melted solder bath at 235 °C \pm 5 °C for 2 s \pm 0.5 s. Flux shall be removed from the surface of termination with clean organic solvent.	

Insulation resistance between substrate and termination shall be measured at DC 100V.

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Thomas	Specification		The set we set he she	
Item	Resistor	Jumper	Test methods	
Resistance to	$\pm (1 \% + 0.05 \Omega)$	Less than	Resistors shall be dipped in the melted solder	
soldering heat	±(1 %+0.03 22)	$50 \text{ m}\Omega$	bath at 270 °C \pm 5 °C for 10s \pm 1s.	
Vibration	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be subjected to a sing vibration having as double amplitude of 1 mm for 2 hours in each three mutual perpendicular directions for total 6 hours. The vibration frequency shall be varie uniformly 10 Hz to 55 Hz and return to 10 H traversing for 1 minute.	
	Without distinct deformation in Solvent solution: Isopropyl alcohol			
Solvent resistance	±(0.5 %+0.05 Ω)	Less than 50 mΩ	 Dipping 10 hours ± 1 hour, dry in room condition for 30 min ± 10 min. Ultrasonic wave washing: 5 min ± 1 min (0.3 W/cm,28 kHz) Dry in room condition for 30 min ± 10 min. 	

8. Environmental Test

Itom	Specification			
Item	Resistor	Jumper	Test methods	
Low temperature exposure	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at -55 °C \pm 3 °C for 1000 hours $^{+48}_{0}$ hours	
Endurance at upper category temperature	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at +125 °C±3 °C f 1000 hours $^{+48}_{0}$ hours.	
Temperature cycling	±(1 %+0.05 Ω)	Less than 50 mΩ	-55 °C ± 3 °C, 30 minutes $\uparrow\downarrow$ Nominal temp., 30minutes 25cycles $\uparrow\downarrow$ +125 °C ± 3 °C, 30minutes	
Humidity (Steady state)	±(1 %+0.05 Ω)	Less than 50 mΩ	Resistors shall be exposed at 60 °C \pm 2 °C an 90 % to 95 % relative humidity in a humidit test chamber for 1000 hours $^{+48}_{-0}$ hours.	
Endurance at 70 °C	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistors shall be exposed at 70 °C \pm 2 °C for 1000 hours $^{+48}_{0}$ hours. During this time, the rated voltage shall be applied intermittent for 1.5 hours ON, 0.5 hour OFF.	
Load life in humidity	±(3 %+0.1 Ω)	Less than 50 mΩ	Resistor shall be exposed at 60 °C \pm 2 °C and 90 % to 95 % relative humidity for 1000 hours ⁴⁴⁸ / ₀ hours. During this time, the rated voltage shall be applied intermittently for 1.5 hour ON, 0.5 hour OFF.	

9. Resistance value marking

No marking.

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10. Notice for use	•
. Notice for use	
 (1)This specification shows the quality and performance of the product in a uni adoption, be sure to evaluate and verify the product mounting it in your produ (2)We take no responsibility for troubles caused by the product usage that is a specification. (3)In traffic transportation equipment (trains, cars, traffic signal equipme equipment, aerospace equipment, electric heating appliances, combustion a rotating equipment, disaster and crime preventive equipment, etc. in cases that the failure of this product gives serious damage to human life and others, and ensure safety by studying the following items to Ensure safety as the system by setting protective circuits and protective exports a dogma shall be occurred about safety for this product, be sure to operate your technical examination. (5) The product is designed to use in general standard applications of general ele (AV products, household electric appliances, office equipment, information an equipment, etc.); hence, it do not take the use under the following special env consideration. Accordingly, the use in the following special environments, and such environmany affect the performance of the product; prior to use, verify the performance thoroughly. 1) Use in liquids such as water, oil, chemical, and organic solvent. 2) Where the product is close to a heating component, or where an inflamma polyvinyl chloride wire is arranged close to the product. 3) Where the product is close to a heating component, or where an inflamma polyvinyl chloride wire is arranged close to the product. 4) Where water or a water-soluble detergent is used in cleaning free soldering the to soluble flux.) 5) Use in such a place where the product is wetted due to dew condensation. 	act. not specified in this nent, etc.), medical and gas equipment, where it is forecast , use fail-safe design equipment. t cause danger by a o inform us rapidly, ctric equipment d communication ironments into mental conditions ee, reliability, etc. ble such as a ing (Pay particular
 6) Use in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂ 7) Use under direct sunlight, in outdoor or in dusty atmospheres. 8) Use in environment with large static electricity or strong electromagnetic (6) If transient load (heavy load on a short time) like pulse is expected to be evaluation and confirmation test with resistors actually mounted on your ov load of more than rated power is applied under the load condition at steady a performance and/or reliability of resistor. Never exceed the rated power. When the product shall be used under special condition, be sure to ask us in a (7) Halogen type (chlorine type, bromine type, etc.) or other high-activity flux is r the residue may affect performance or reliability of resistors. (8) When soldering with soldering iron, never touch the body of the chip resist soldering iron. When using a soldering iron with a tip at high temperature, short as possible. (Three seconds or less up to 350 °C) 	waves. e applied, carry out vn board. When the state, it may impair dvance. not recommended as or with a tip of the
 (9)Avoid physical shock to the resistor and nipping of the resistor with hard too tweezers) as it may damage protective firm or the body of resistor and n performance. (10)Reflow soldering method shall apply to this product in principle. 	

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11. Storage method

If the product is stored in the following environments and conditions, the performance and solderability may be badly affected. Avoid the storage in the following environments.

- (1) Storage in places full of corrosive gases such as sea breeze, Cl₂, H₂S, NH₃, SO₂, and NO_X.
- (2) Storage in places exposed to direct sunlight.
- (3) Storage in places outside the temperature range of 5 °C to 35 °C and humidity range of 45 %RH to 85 %RH.
- (4) Storage over a year after our delivery (This item also applies to the case where the storage method specified in item (1) to (3) has been followed.).

12. Laws and Regulations

- (1) No ODCs or other ozone-depleting substances that are subject to regulation under the Montreal Protocol are used in our manufacturing processes, including in the manufacture of this product.
- (2) This product complies with the RoHS Directive (Restriction of the use of certain Hazardous Substances in electrical and electronic equipment (DIRECTIVE 2002/95/EC)).
- (3) All materials used in this product are existing chemical substances recognized under "lows on examination of chemical substances and regulations of manufacturing and others."
- (4) None of the materials used in this product contain the designated incombustible bromic substances, PBBOs and PBBs.
- (5) Please contact us to obtain a notice as to whether this product has passed inspection under review criteria primarily based on Foreign Exchange and Foreign Trade Control Laws, and appended table in the Export Control Laws.

13. Production Place

Production Country :Japan

Production Plant : Panasonic Electronic Devices Japan Co.,Ltd.

Production Country : China

Production Plant : Panasonic Electronic Devices (Tianjin) Co., Ltd.(PEDTJ)

Production Country : Malaysia

Production Plant : Panasonic Electronic Devices Malaysia Sdn. Bhd. (PEDMA)



- 14-3-1. Taping
 - (1) When the test shall be operated with the below conditions, peel strength should be $0.049\mathrm{N}$

to 0.49N, should not have flash and tear after peeling.

<Test Method>



(2) Minimum Bending Radius

When carrier tape shall be bent by minimum bending radius (15 mm), no defection of chip and no break of carrier tape. However minimum bending radius shall be tested for 1 times.

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(3) Resistance to clim		·

When resistors shall be exposed at 60 °C \pm 2 °C, 90 %RH to 95 %RH for 120 hours, no defection of chip and no break off carrier tape.

When the top tape shall be peeled, tape should not have flash and tear.

14-3-2. Quantity in Taping: 10,000 pcs. / reel

14-3-3. Tape packaging

- (1) Resistor side shall be facing upward.
- (2) Chip resistor shall not be sticking to top tape and bottom tape.
- (3) Chip resistors shall be easy to take out from carrier tape and chip hole or sprocket hole shall not have flash and break.

14-4. Outer Packaging

Quantity: 20 reels(Max.200,000 pcs.)



- (1) When packaging quantity does not reach max quantity, the remaining empty space shall be buried with buffer material.
- (2) When quantity shall be few, alternative packaging methods may used. No problem must occur during the exportation of the product..

14-5. Marking

At last, production country is displayed in English.

- Side of reel (Marking shall be on one side.)
 - (1)Part name(2)Part number(3)Quantity(4)Lot number(5)Maker name(6)Production country
- Packaging box

(1)Customer name(2)Part name(3)Part number(4)Customer part number(5)Quantity(6)Maker name(7) Production country



Chip Resistor Array PRODUCT SPECIFICATION FOR INFORMATION

Attached Sheet

APPEARANCE QUALITY CRITERIA

1-1

Item	Defect Criteria	Appearance Criteria	Remark
Resin Chipping		A \leq W/8 B \leq C/2	Both side chipping shall be judged defect
Terminal Chipping	C A A M M M M	A ≤ C/4 B ≤ Top terminal width	
Pin Hole		One pin hole / chip resistor φ ≤ 0.2 mm	This item is applied to pin holes which reach to the resistive materials
Flash	$\rightarrow \downarrow \Leftarrow^{A}$	A ≤ 100 μm	